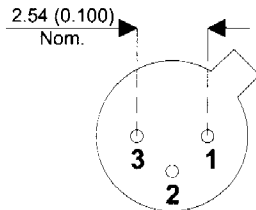
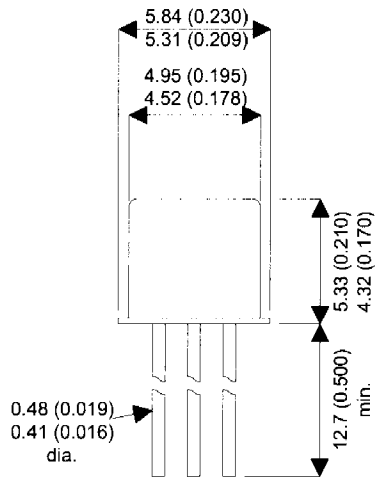


**BSS74**

**MECHANICAL DATA**

Dimensions in mm (inches)



**TO-18 (TO-206AA) PACKAGE**

PIN 1 – Emitter    PIN 2 – Base    PIN 3 – Collector

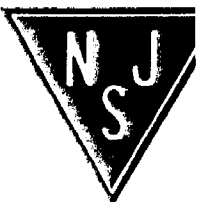
**HIGH VOLTAGE  
 PNP SILICON  
 TRANSISTOR**

**FEATURES**

- Hermetic Metal Package
- Screening Options Available

**ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^\circ\text{C}$  unless otherwise stated)

$V_{CBO}$	Collector – Base Voltage		-200V
$V_{CEO}$	Collector – Emitter Voltage		-200V
$V_{EBO}$	Emitter – Base Voltage		-5V
$I_C$	Continuous Collector Current		-0.5A
$P_D$	Total Device Dissipation	$T_A = 25^\circ\text{C}$	0.5W
		Derate above $25^\circ\text{C}$	2.86mW/ $^\circ\text{C}$
$P_D$	Total Device Dissipation	$T_C = 25^\circ\text{C}$	2.5W
		Derate above $25^\circ\text{C}$	14.3mW/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating Junction & Storage Temperature Range		-65 to $200^\circ\text{C}$
$R_{\theta JC}$	Thermal Resistance, Junction – Case		$70^\circ\text{C/W}$



## ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit		
<b>OFF CHARACTERISTICS</b>							
V <sub>(BR)CEO</sub>	Collector – Emitter Breakdown Voltage	I <sub>C</sub> = -10mA	I <sub>B</sub> = 0	-200	V		
V <sub>(BR)CBO</sub>	Collector – Base Breakdown Voltage	I <sub>C</sub> = -100μA	I <sub>E</sub> = 0	-200			
V <sub>(BR)EBO</sub>	Emitter – Base Breakdown Voltage	I <sub>E</sub> = 100μA	I <sub>C</sub> = 0	-6			
I <sub>CBO</sub>	Collector Cut-off Current	V <sub>CB</sub> = -150V	I <sub>E</sub> = 0	-50	nA		
I <sub>CEO</sub>	Collector Cut-off Current	V <sub>CE</sub> = -150V	I <sub>B</sub> = 0	-500			
I <sub>EBO</sub>	Emitter Cut-off Current	V <sub>BE</sub> = -5V	I <sub>C</sub> = 0	-50			
<b>ON CHARACTERISTICS</b>							
h <sub>FE</sub>	DC Current Gain	V <sub>CE</sub> = -1V	I <sub>C</sub> = -0.1mA	20	40	—	
		V <sub>CE</sub> = -10V	I <sub>C</sub> = -1mA	30	45		
		V <sub>CE</sub> = -10V	I <sub>C</sub> = -10mA	35	50		
		V <sub>CE</sub> = -10V	I <sub>C</sub> = -30mA	35	55		150
V <sub>CE(sat)</sub>	Collector – Emitter Saturation Voltage	I <sub>C</sub> = -10mA	I <sub>B</sub> = -1mA	-0.3	V		
		I <sub>C</sub> = -30mA	I <sub>B</sub> = -3mA	-0.4			
V <sub>BE(sat)</sub>	Base – Emitter Saturation Voltage	I <sub>C</sub> = -10mA	I <sub>B</sub> = -1mA	-0.8	V		
		I <sub>C</sub> = -30mA	I <sub>B</sub> = -3mA	-0.9			
<b>DYNAMIC CHARACTERISTICS</b>							
f <sub>T</sub>	Current Gain Bandwidth Product	I <sub>C</sub> = -20mA	V <sub>CE</sub> = -20V	50	110	200	MHz
C <sub>ob</sub>	Output Capacitance	I <sub>E</sub> = 0	V <sub>CB</sub> = -20V		3.5		pF
		f = 1MHz					
C <sub>ib</sub>	Input Capacitance	I <sub>C</sub> = 0	V <sub>EB</sub> = -0.5V		45		
		f = 1MHz					
t <sub>on</sub>	Turn-On Time	I <sub>B1</sub> = -10mA	I <sub>C</sub> = -50mA		100		ns
t <sub>off</sub>	Turn-Off Time	I <sub>B2</sub> = -10mA	I <sub>C</sub> = -50mA		400		
		V <sub>CC</sub> = -100V					
		V <sub>CC</sub> = -100V					

\* Pulse Test: t<sub>p</sub> ≤ 300μs, d ≤ 2%.